

DS25CP102 3.125 Gbps 2X2 LVDS Crosspoint Switch with Transmit Pre-Emphasis and Receive Equalization

Check for Samples: [DS25CP102](#)

FEATURES

- DC - 3.125 Gbps Low Jitter, Low Skew, Low Power Operation
- Pin Configurable, Fully Differential, Non-Blocking Architecture
- Pin Selectable Transmit Pre-Emphasis and Receive Equalization Eliminate Data Dependant Jitter
- Wide Input Common Mode Voltage Range Allows DC-Coupled Interface to CML and LVPECL Drivers
- On-Chip 100 Ω Input and Output Termination Minimizes Insertion and Return Losses, Reduces Component Count, Minimizes Board Space
- 8 kV ESD on LVDS I/O Pins Protects Adjoining Components
- Small 4 mm x 4 mm WQFN-16 Space Saving Package

APPLICATIONS

- High-Speed Channel Select Applications
- Clock and Data Buffering and Muxing
- OC-48 / STM-16
- SD/HD/3GHD SDI Routers

DESCRIPTION

The DS25CP102 is a 3.125 Gbps 2x2 LVDS crosspoint switch optimized for high-speed signal routing and switching over lossy FR-4 printed circuit board backplanes and balanced cables. Fully differential signal paths ensure exceptional signal integrity and noise immunity. The non-blocking architecture allows connections of any input to any output or outputs.

The DS25CP102 features two levels (Off and On) of transmit pre-emphasis (PE) and two levels (Off and On) of receive equalization (EQ).

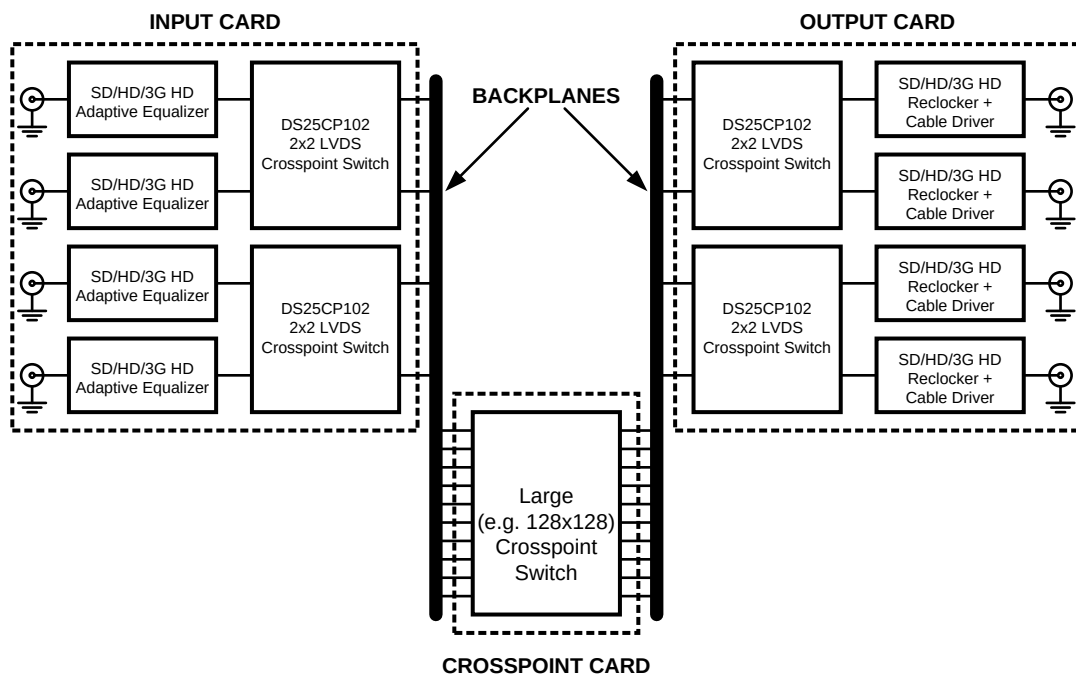
Wide input common mode range allows the switch to accept signals with LVDS, CML and LVPECL levels; the output levels are LVDS. A very small package footprint requires a minimal space on the board while the flow-through pinout allows easy board layout. Each differential input and output is internally terminated with a 100 Ω resistor to lower device insertion and return losses, reduce component count and further minimize board space.



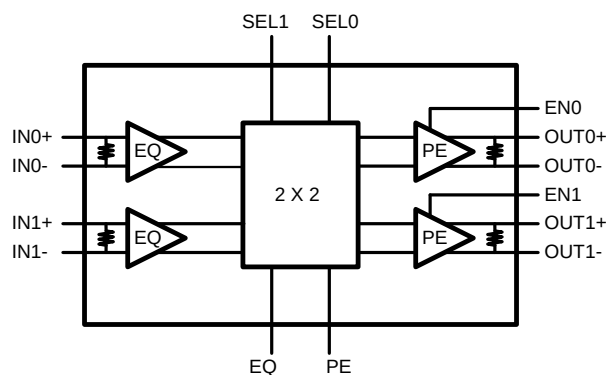
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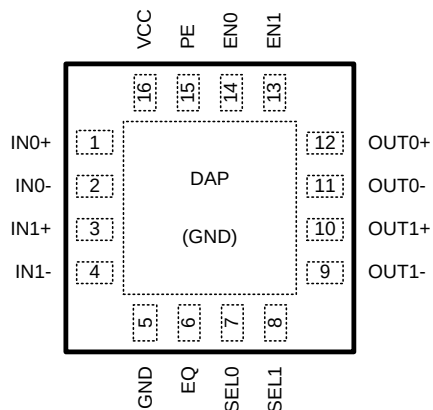
Typical Application



Block Diagram



Connection Diagram



PIN DESCRIPTIONS

Pin Name	Pin Number	I/O, Type	Pin Description
IN0+, IN0-, IN1+, IN1-	1, 2, 3, 4	I, LVDS	Inverting and non-inverting high speed LVDS input pins.
OUT0+, OUT0-, OUT1+, OUT1-	12, 11, 10, 9	O, LVDS	Inverting and non-inverting high speed LVDS output pins.
SEL0, SEL1	7, 8	I, LVCMOS	Switch configuration pins. There is a 20k pulldown resistor on this pin.
EN0, EN1	14, 13	I, LVCMOS	Output enable pins. There is a 20k pulldown resistor on this pin.
PE	15	I, LVCMOS	Transmit Pre-Emphasis select pin. There is a 20k pulldown resistor on this pin.
EQ	6	I, LVCMOS	Receive Equalization select pin. There is a 20k pulldown resistor on this pin.
VDD	16	Power	Power supply pin.
GND	5, DAP	Power	Ground pin and Device Attach Pad (DAP) ground.



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

Absolute Maximum Ratings⁽¹⁾⁽²⁾

Supply Voltage	–0.3V to +4V
LVCMOS Input Voltage	–0.3V to (V _{CC} + 0.3V)
LVDS Input Voltage	–0.3V to +4V
Differential Input Voltage VID	1.0V
LVDS Output Voltage	–0.3V to (V _{CC} + 0.3V)
LVDS Differential Output Voltage	0V to 1.0V
LVDS Output Short Circuit Current Duration	5 ms
Junction Temperature	+150°C
Storage Temperature Range	–65°C to +150°C
Lead Temperature Range	
Soldering (4 sec.)	+260°C
Maximum Package Power Dissipation at 25°C	
RGH0016A Package	2.99W
Derate RGH0016A Package	23.9 mW/°C above +25°C
Package Thermal Resistance	
θ _{JA}	+41.8°C/W
θ _{JC}	+6.9°C/W
ESD Susceptibility	
HBM ⁽³⁾	≥8 kV
MM ⁽⁴⁾	≥250V
CDM ⁽⁵⁾	≥1250V

- (1) "Absolute Maximum Ratings" indicate limits beyond which damage to the device may occur, including inoperability and degradation of device reliability and/or performance. Functional operation of the device and/or non-degradation at the [Absolute Maximum Ratings](#) or other conditions beyond those indicated in the [Recommended Operating Conditions](#) is not implied. The Recommended Operating Conditions indicate conditions at which the device is functional and the device should not be operated beyond such conditions.
- (2) If Military/Aerospace specified devices are required, please contact the TI Sales Office/Distributors for availability and specifications.
- (3) Human Body Model, applicable std. JESD22-A114C
- (4) Machine Model, applicable std. JESD22-A115-A
- (5) Field Induced Charge Device Model, applicable std. JESD22-C101-C

Recommended Operating Conditions

	Min	Typ	Max	Units
Supply Voltage (V_{CC})	3.0	3.3	3.6	V
Receiver Differential Input Voltage (V_{ID})	0		1	V
Operating Free Air Temperature (T_A)	-40	+25	+85	°C

DC Electrical Characteristics⁽¹⁾⁽²⁾⁽³⁾

Over recommended operating supply and temperature ranges unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Units
LVCMOS DC SPECIFICATIONS						
V_{IH}	High Level Input Voltage		2.0		V_{CC}	V
V_{IL}	Low Level Input Voltage		GND		0.8	V
I_{IH}	High Level Input Current	$V_{IN} = 3.6V$ $V_{CC} = 3.6V$	40	175	250	μA
I_{IL}	Low Level Input Current	$V_{IN} = GND$ $V_{CC} = 3.6V$		0	±10	μA
V_{CL}	Input Clamp Voltage	$I_{CL} = -18\text{ mA}$, $V_{CC} = 0V$		-0.9	-1.5	V
LVDS INPUT DC SPECIFICATIONS						
V_{ID}	Input Differential Voltage		0		1	V
V_{TH}	Differential Input High Threshold	$V_{CM} = +0.05V$ or $V_{CC}-0.05V$		0	+100	mV
V_{TL}	Differential Input Low Threshold		-100	0		mV
V_{CMR}	Common Mode Voltage Range	$V_{ID} = 100\text{ mV}$	0.05		$V_{CC} - 0.05$	V
I_{IN}	Input Current	$V_{IN} = +3.6V$ or $0V$ $V_{CC} = 3.6V$ or $0V$		±1	±10	μA
C_{IN}	Input Capacitance	Any LVDS Input Pin to GND		1.7		pF
R_{IN}	Input Termination Resistor	Between IN+ and IN-		100		Ω
LVDS OUTPUT DC SPECIFICATIONS						
V_{OD}	Differential Output Voltage	$R_L = 100\Omega$	250	350	450	mV
ΔV_{OD}	Change in Magnitude of V_{OD} for Complimentary Output States		-35		35	mV
V_{OS}	Offset Voltage	$R_L = 100\Omega$	1.05	1.2	1.375	V
ΔV_{OS}	Change in Magnitude of V_{OS} for Complimentary Output States		-35		35	mV
I_{OS}	Output Short Circuit Current ⁽⁴⁾	OUT to GND		-35	-55	mA
		OUT to V_{CC}		7	55	mA
C_{OUT}	Output Capacitance	Any LVDS Output Pin to GND		1.2		pF
R_{OUT}	Output Termination Resistor	Between OUT+ and OUT-		100		Ω
SUPPLY CURRENT						
I_{CC}	Supply Current	PE = OFF, EQ = OFF		77	90	mA
I_{CCZ}	Supply Current with Outputs Disabled	EN0 = EN1 = 0		23	29	mA

- (1) The Electrical Characteristics tables list guaranteed specifications under the listed [Recommended Operating Conditions](#) except as otherwise modified or specified by the Electrical Characteristics Conditions and/or Notes. Typical specifications are estimations only and are not guaranteed.
- (2) Current into device pins is defined as positive. Current out of device pins is defined as negative. All voltages are referenced to ground except V_{OD} and ΔV_{OD} .
- (3) Typical values represent most likely parametric norms for $V_{CC} = +3.3V$ and $T_A = +25^\circ\text{C}$, and at the Recommended Operation Conditions at the time of product characterization and are not guaranteed.
- (4) Output short circuit current (I_{OS}) is specified as magnitude only, minus sign indicates direction only.

AC Electrical Characteristics ⁽¹⁾

Over recommended operating supply and temperature ranges unless otherwise specified. ⁽²⁾ ⁽³⁾

Symbol	Parameter	Conditions	Min	Typ	Max	Units	
LVDS OUTPUT AC SPECIFICATIONS							
t _{PLHD}	Differential Propagation Delay Low to High	R _L = 100Ω		365	500	ps	
t _{PHLD}	Differential Propagation Delay High to Low			345	500	ps	
t _{SKD1}	Pulse Skew t _{PLHD} - t _{PHLD} ⁽⁴⁾			20	55	ps	
t _{SKD2}	Channel to Channel Skew ⁽⁵⁾			12	25	ps	
t _{SKD3}	Part to Part Skew , ⁽⁶⁾			50	150	ps	
t _{LHT}	Rise Time	R _L = 100Ω		65	120	ps	
t _{HLT}	Fall Time			65	120	ps	
t _{ON}	Output Enable Time	ENn = LH to output active		7	20	μs	
t _{OFF}	Output Disable Time	ENn = HL to output inactive		5	12	ns	
t _{SEL}	Select Time	SELn LH or HL to output		3.5	12	ns	
JITTER PERFORMANCE WITH EQ = Off, PE = Off (Figure 5)							
t _{RJ1}	Random Jitter (RMS Value)	V _{ID} = 350 mV	2.5 Gbps		0.5	1	ps
t _{RJ2}	No Test Channels ⁽⁷⁾	V _{CM} = 1.2V Clock (RZ)	3.125 Gbps		0.5	1	ps
t _{DJ1}	Deterministic Jitter (Peak to Peak)	V _{ID} = 350 mV	2.5 Gbps		6	22	ps
t _{DJ2}	No Test Channels ⁽⁸⁾	V _{CM} = 1.2V K28.5 (NRZ)	3.125 Gbps		6	22	ps
t _{TJ1}	Total Jitter (Peak to Peak)	V _{ID} = 350 mV	2.5 Gbps		0.03	0.08	UI _{P-P}
t _{TJ2}	No Test Channels ⁽⁹⁾	V _{CM} = 1.2V PRBS-23 (NRZ)	3.125 Gbps		0.05	0.11	UI _{P-P}
JITTER PERFORMANCE WITH EQ = Off, PE = On (Figure 6, Figure 9)							
t _{RJ1B}	Random Jitter (RMS Value)	V _{ID} = 350 mV	2.5 Gbps		0.5	1	ps
t _{RJ2B}	Test Channel B ⁽⁷⁾	V _{CM} = 1.2V Clock (RZ)	3.125 Gbps		0.5	1	ps
t _{DJ1B}	Deterministic Jitter (Peak to Peak)	V _{ID} = 350 mV	2.5 Gbps		3	12	ps
t _{DJ2B}	Test Channel B ⁽⁸⁾	V _{CM} = 1.2V K28.5 (NRZ)	3.125 Gbps		3	12	ps
t _{TJ1B}	Total Jitter (Peak to Peak)	V _{ID} = 350 mV	2.5 Gbps		0.03	0.06	UI _{P-P}
t _{TJ2B}	Test Channel B ⁽⁹⁾	V _{CM} = 1.2V PRBS-23 (NRZ)	3.125 Gbps		0.04	0.09	UI _{P-P}
JITTER PERFORMANCE WITH EQ = On, PE = Off (Figure 7, Figure 9)							
t _{RJ1D}	Random Jitter (RMS Value)	V _{ID} = 350 mV	2.5 Gbps		0.5	1	ps
t _{RJ2D}	Test Channel D ⁽⁷⁾	V _{CM} = 1.2V Clock (RZ)	3.125 Gbps		0.5	1	ps
t _{DJ1D}	Deterministic Jitter (Peak to Peak)	V _{ID} = 350 mV	2.5 Gbps		16	24	ps
t _{DJ2D}	Test Channel D ⁽⁸⁾	V _{CM} = 1.2V K28.5 (NRZ)	3.125 Gbps		12	24	ps

- (1) Specification is guaranteed by characterization and is not tested in production.
- (2) The Electrical Characteristics tables list guaranteed specifications under the listed [Recommended Operating Conditions](#) except as otherwise modified or specified by the Electrical Characteristics Conditions and/or Notes. Typical specifications are estimations only and are not guaranteed.
- (3) Typical values represent most likely parametric norms for $V_{CC} = +3.3\text{V}$ and $T_A = +25^\circ\text{C}$, and at the Recommended Operation Conditions at the time of product characterization and are not guaranteed.
- (4) t_{SKD1} , $|t_{PLHD} - t_{PHLD}|$, Pulse Skew, is the magnitude difference in differential propagation delay time between the positive going edge and the negative going edge of the same channel.
- (5) t_{SKD2} , Channel to Channel Skew, is the difference in propagation delay (t_{PLHD} or t_{PHLD}) among all output channels in Broadcast mode (any one input to all outputs).
- (6) t_{SKD3} , Part to Part Skew, is defined as the difference between the minimum and maximum differential propagation delays. This specification applies to devices at the same V_{CC} and within 5°C of each other within the operating temperature range.
- (7) Measured on a clock edge with a histogram and an accumulation of 1500 histogram hits. Input stimulus jitter is subtracted geometrically.
- (8) Tested with a combination of the 1100000101 (K28.5+ character) and 0011111010 (K28.5- character) patterns. Input stimulus jitter is subtracted algebraically.
- (9) Measured on an eye diagram with a histogram and an accumulation of 3500 histogram hits. Input stimulus jitter is subtracted.

AC Electrical Characteristics ⁽¹⁾ (continued)

Over recommended operating supply and temperature ranges unless otherwise specified. ⁽²⁾ ⁽³⁾

Symbol	Parameter	Conditions	Min	Typ	Max	Units
t_{TJ1D}	Total Jitter (Peak to Peak)	$V_{ID} = 350\text{ mV}$				
t_{TJ2D}	Test Channel D	$V_{CM} = 1.2\text{V}$				
	(9)	PRBS-23 (NRZ)				
		2.5 Gbps		0.07	0.11	UI _{P-P}
		3.125 Gbps		0.07	0.11	UI _{P-P}
JITTER PERFORMANCE WITH EQ = On, PE = On (Figure 8, Figure 9)						
t_{RJ1BD}	Random Jitter (RMS Value)	$V_{ID} = 350\text{ mV}$				
t_{RJ2BD}	Input Test Channel D	$V_{CM} = 1.2\text{V}$				
	Output Test Channel B	Clock (RZ)				
	(7)	2.5 Gbps		0.5	1	ps
		3.125 Gbps		0.5	1	ps
t_{DJ1BD}	Deterministic Jitter (Peak to Peak)	$V_{ID} = 350\text{ mV}$				
t_{DJ2BD}	Input Test Channel D	$V_{CM} = 1.2\text{V}$				
	Output Test Channel B	K28.5 (NRZ)				
	(8)	2.5 Gbps		14	31	ps
		3.125 Gbps		6	21	ps
t_{TJ1BD}	Total Jitter (Peak to Peak)	$V_{ID} = 350\text{ mV}$				
t_{TJ2BD}	Input Test Channel D	$V_{CM} = 1.2\text{V}$				
	Output Test Channel B	PRBS-23 (NRZ)				
	(9)	2.5 Gbps		0.08	0.15	UI _{P-P}
		3.125 Gbps		0.10	0.16	UI _{P-P}

DC TEST CIRCUITS

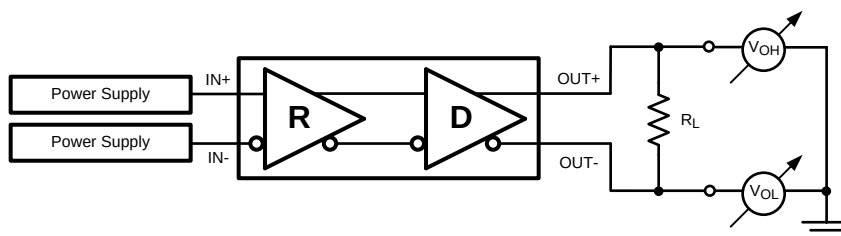


Figure 1. Differential Driver DC Test Circuit

AC Test Circuits and Timing Diagrams

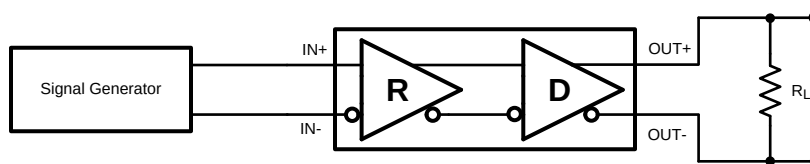


Figure 2. Differential Driver AC Test Circuit

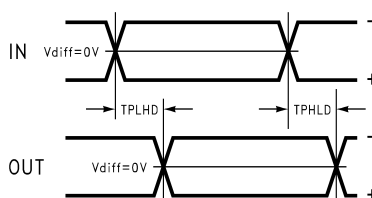


Figure 3. Propagation Delay Timing Diagram

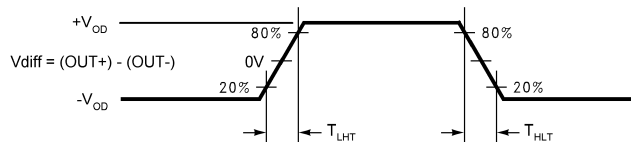


Figure 4. LVDS Output Transition Times

Pre-Emphasis and Equalization Test Circuits

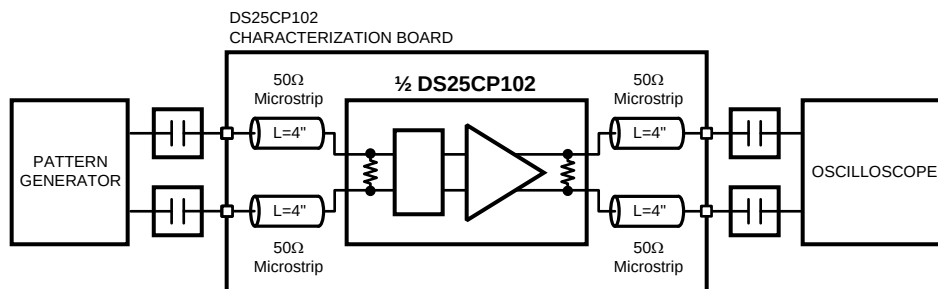


Figure 5. Jitter Performance Test Circuit

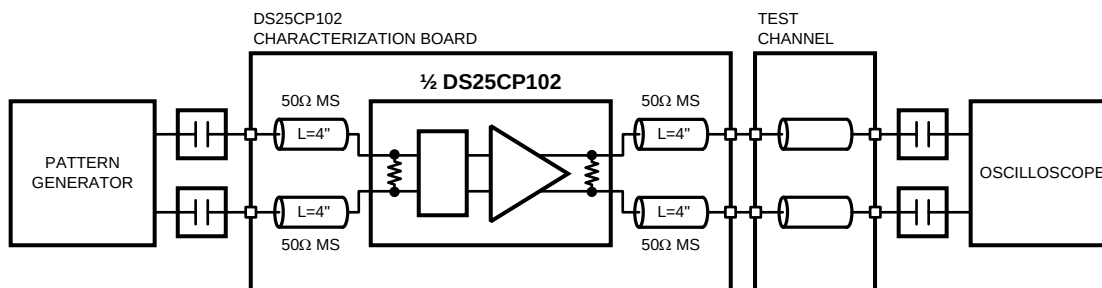


Figure 6. Pre-Emphasis Performance Test Circuit

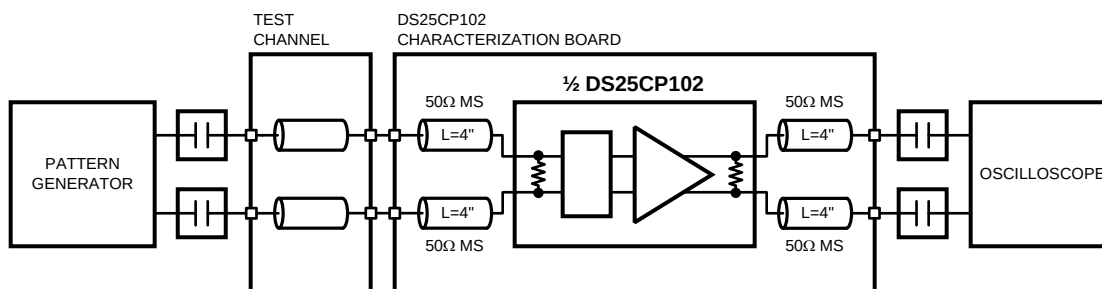


Figure 7. Equalization Performance Test Circuit

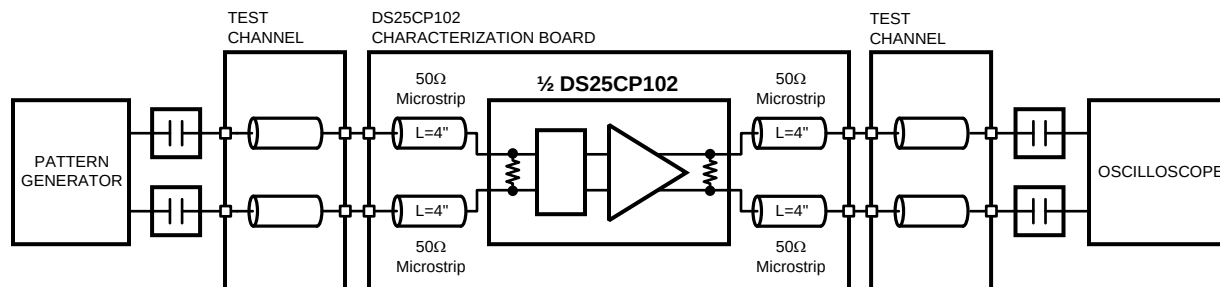


Figure 8. Pre-Emphasis and Equalization Performance Test Circuit

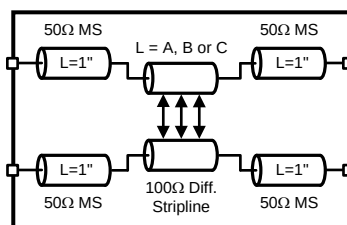


Figure 9. Test Channel Block Diagram

Test Channel Loss Characteristics

The test channel was fabricated with Polyclad PCL-FR-370-Laminate/PCL-FRP-370 Prepreg materials (Dielectric constant of 3.7 and Loss Tangent of 0.02). The edge coupled differential striplines have the following geometries: Trace Width (W) = 5 mils, Gap (S) = 5 mils, Height (B) = 16 mils.

Test Channel	Length (inches)	Insertion Loss (dB)					
		500 MHz	750 MHz	1000 MHz	1250 MHz	1500 MHz	1560 MHz
A	10	-1.2	-1.7	-2.0	-2.4	-2.7	-2.8
B	20	-2.6	-3.5	-4.1	-4.8	-5.5	-5.6
C	30	-4.3	-5.7	-7.0	-8.2	-9.4	-9.7
D	15	-1.6	-2.2	-2.7	-3.2	-3.7	-3.8
E	30	-3.4	-4.5	-5.6	-6.6	-7.7	-7.9
F	60	-7.8	-10.3	-12.4	-14.5	-16.6	-17.0

Functional Description

The DS25CP102 is a 3.125 Gbps 2x2 LVDS digital crosspoint switch optimized for high-speed signal routing and switching over lossy FR-4 printed circuit board backplanes and balanced cables.

Table 1. Switch Configuration Truth Table

SEL1	SEL0	OUT1	OUT0
0	0	IN0	IN0
0	1	IN0	IN1
1	0	IN1	IN0
1	1	IN1	IN1

Table 2. Output Enable Truth Table

EN1	EN0	OUT1	OUT0
0	0	Disabled	Disabled
0	1	Disabled	Enabled
1	0	Enabled	Disabled
1	1	Enabled	Enabled

In addition, the DS25CP102 has a pre-emphasis control pin for switching the transmit pre-emphasis to ON and OFF setting and an equalization control pin for switching the receive equalization to ON and OFF setting. The following are the transmit pre-emphasis and receive equalization truth tables.

Table 3. Transmit Pre-Emphasis Truth Table⁽¹⁾

OUTPUTS OUT0 and OUT1	
CONTROL Pin (PE) State	Pre-Emphasis Level
0	OFF
1	ON

(1) Transmit Pre-Emphasis Level Selection

Table 4. Receive Equalization Truth Table⁽¹⁾

INPUTS IN0 and IN1	
CONTROL Pin (EQ) State	Equalization Level
0	OFF
1	ON

(1) Receive Equalization Level Selection

Input Interfacing

The DS25CP102 accepts differential signals and allows simple AC or DC coupling. With a wide common mode range, the DS25CP102 can be DC-coupled with all common differential drivers (i.e. LVPECL, LVDS, CML). The following three figures illustrate typical DC-coupled interface to common differential drivers. Note that the DS25CP102 inputs are internally terminated with a 100Ω resistor.

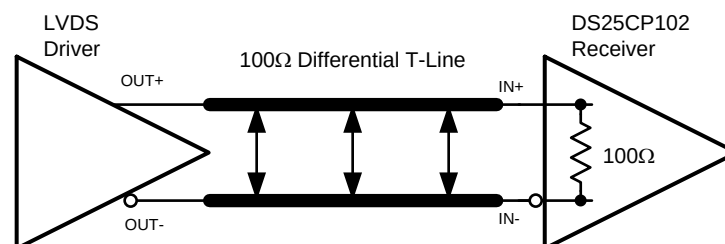


Figure 10. Typical LVDS Driver DC-Coupled Interface to DS25CP102 Input

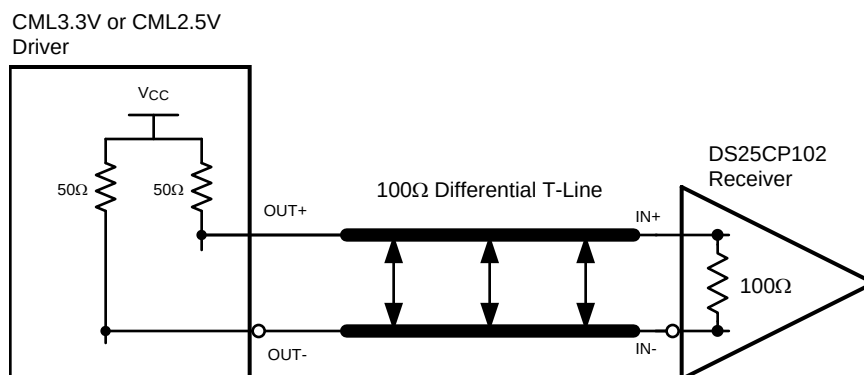


Figure 11. Typical CML Driver DC-Coupled Interface to DS25CP102 Input

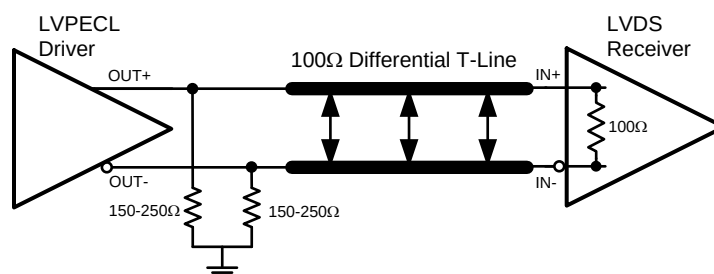


Figure 12. Typical LVPECL Driver DC-Coupled Interface to DS25CP102 Input

Output Interfacing

The DS25CP102 outputs signals that are compliant to the LVDS standard. Its outputs can be DC-coupled to most common differential receivers. The following figure illustrates typical DC-coupled interface to common differential receivers and assumes that the receivers have high impedance inputs. While most differential receivers have a common mode input range that can accommodate LVDS compliant signals, it is recommended to check respective receiver's data sheet prior to implementing the suggested interface implementation.

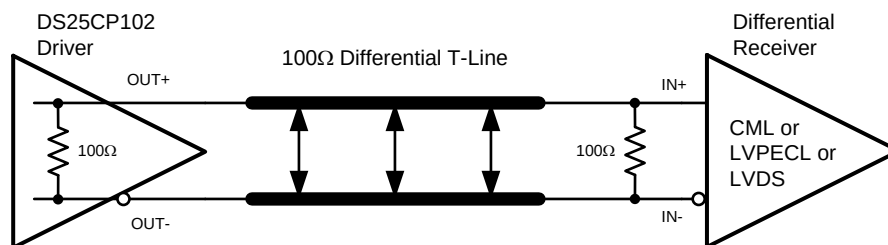


Figure 13. Typical DS25CP102 Output DC-Coupled Interface to an LVDS, CML or LVPECL Receiver

Typical Performance Characteristics

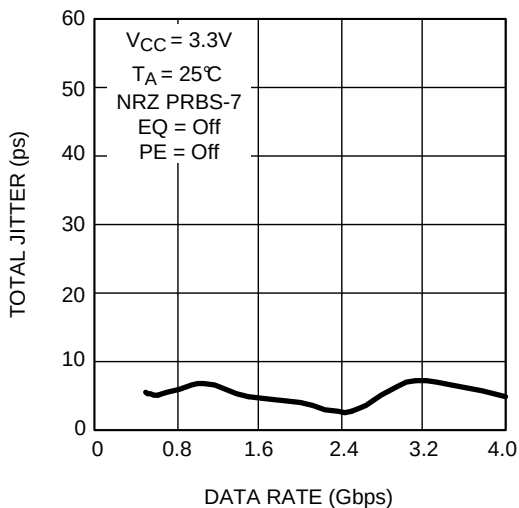


Figure 14. Total Jitter as a Function of Data Rate

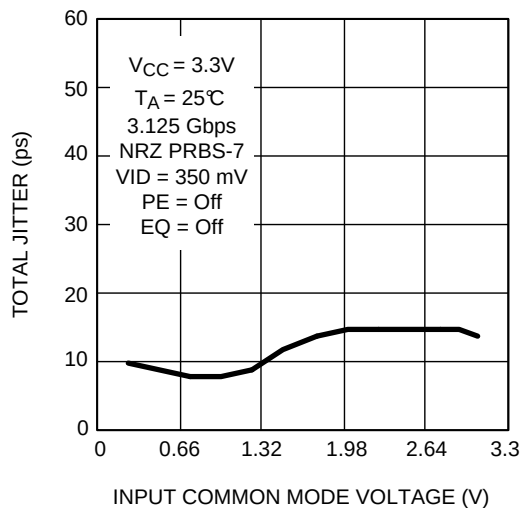


Figure 15. Total Jitter as a Function of Input Common Mode Voltage

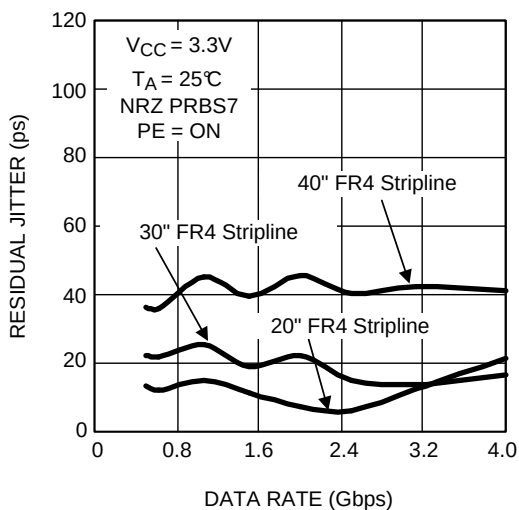


Figure 16. Residual Jitter as a Function of Data Rate, FR4 Stripline Length and PE Level

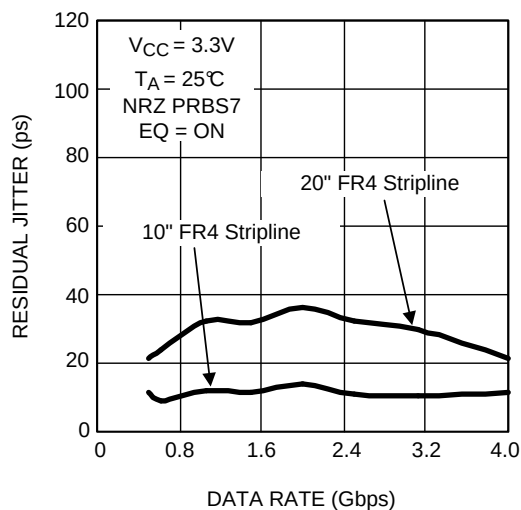


Figure 17. Residual Jitter as a Function of Data Rate, FR4 Stripline Length and EQ Level

Typical Performance Characteristics (continued)

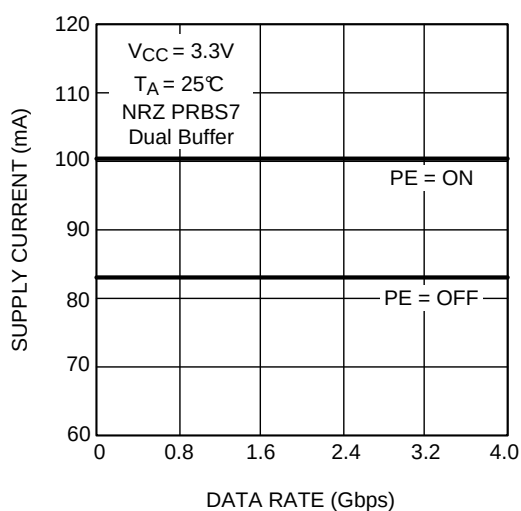


Figure 18. Supply Current as a Function of Data Rate and PE Level

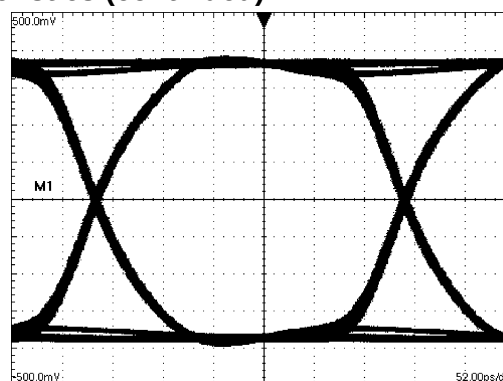


Figure 19. A 3.125 Gbps NRZ PRBS-7 without PE or EQ After 2" Differential FR-4 Stripline
H: 50 ps / DIV, V: 100 mV / DIV

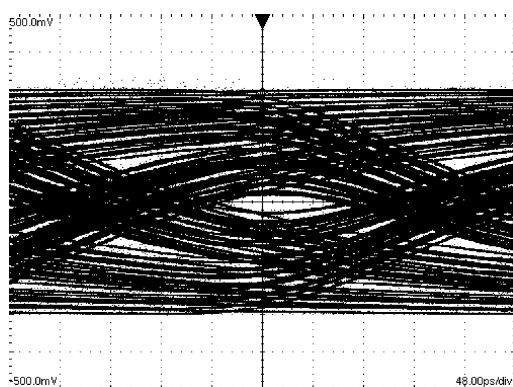


Figure 20. A 3.125 Gbps NRZ PRBS-7 without PE or EQ After 40" Differential FR-4 Stripline
H: 50 ps / DIV, V: 100 mV / DIV

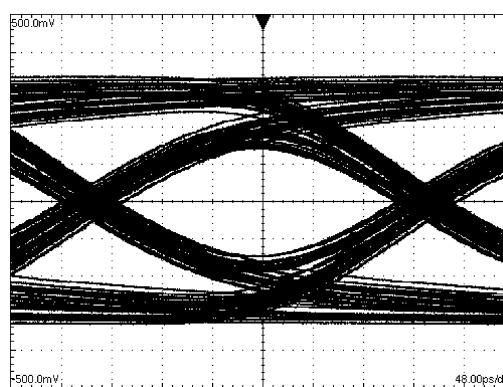


Figure 21. A 3.125 Gbps NRZ PRBS-7 with PE After 40" Differential FR-4 Stripline
H: 50 ps / DIV, V: 100 mV / DIV

REVISION HISTORY

Changes from Revision D (March 2013) to Revision E	Page
• Changed layout of National Data Sheet to TI format	12

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
DS25CP102TSQ/NOPB	Active	Production	WQFN (RGH) 16	1000 SMALL T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 85	2C102SQ
DS25CP102TSQ/NOPB.A	Active	Production	WQFN (RGH) 16	1000 SMALL T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 85	2C102SQ

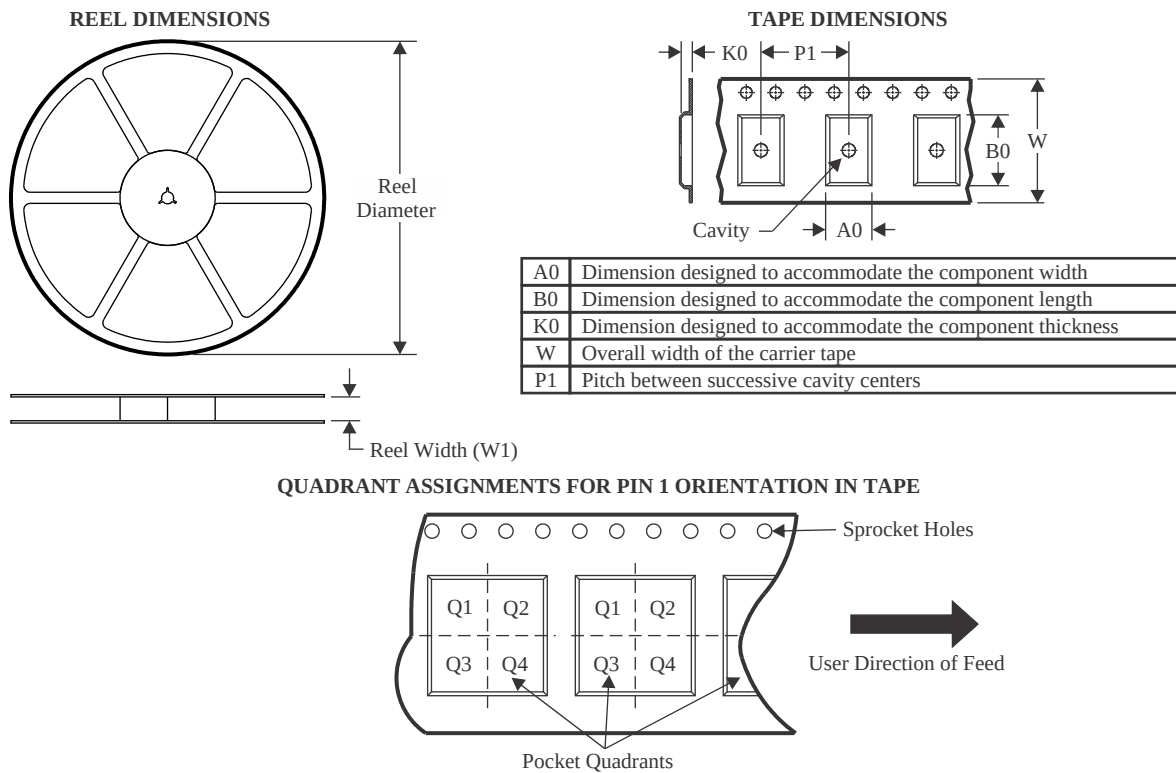
- ⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).
- ⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.
- ⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.
- ⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.
- ⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.
- ⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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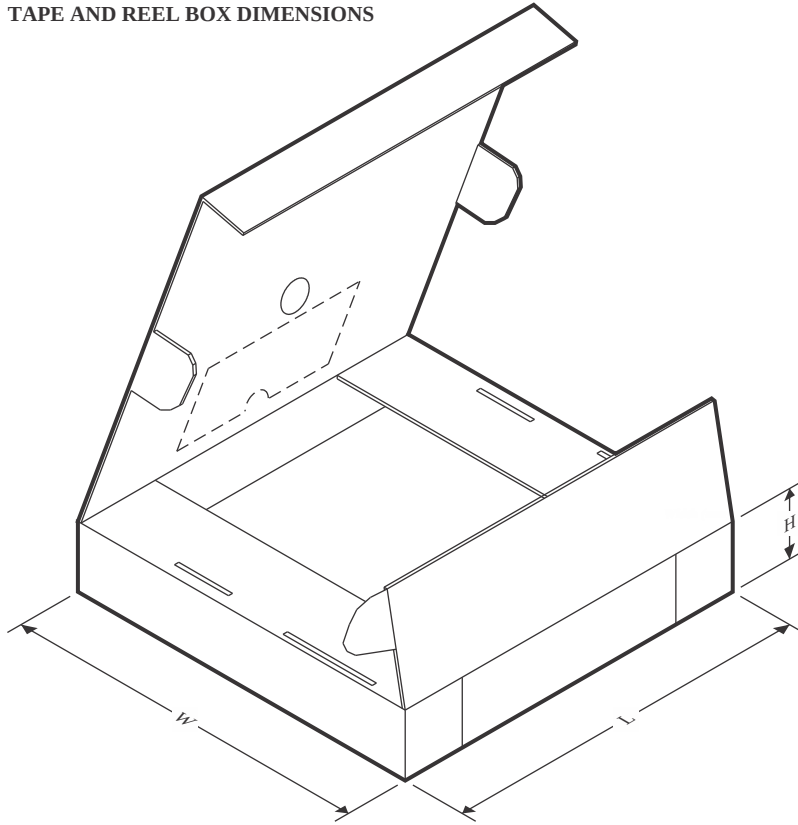
TAPE AND REEL INFORMATION



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
DS25CP102TSQ/NOPB	WQFN	RGH	16	1000	177.8	12.4	4.3	4.3	1.3	8.0	12.0	Q1

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

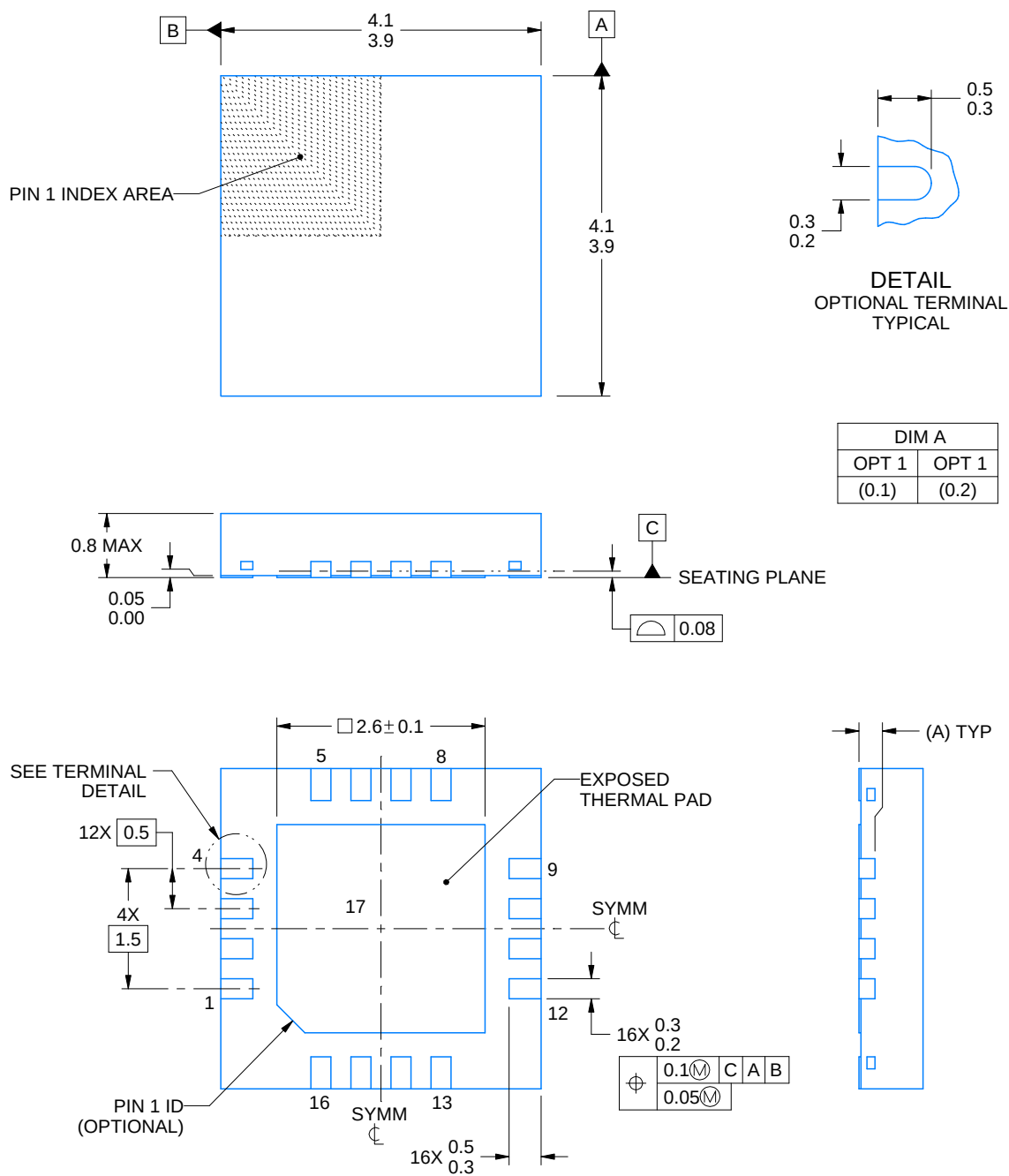
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
DS25CP102TSQ/NOPB	WQFN	RGH	16	1000	210.0	185.0	35.0



PACKAGE OUTLINE

WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



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NOTES:

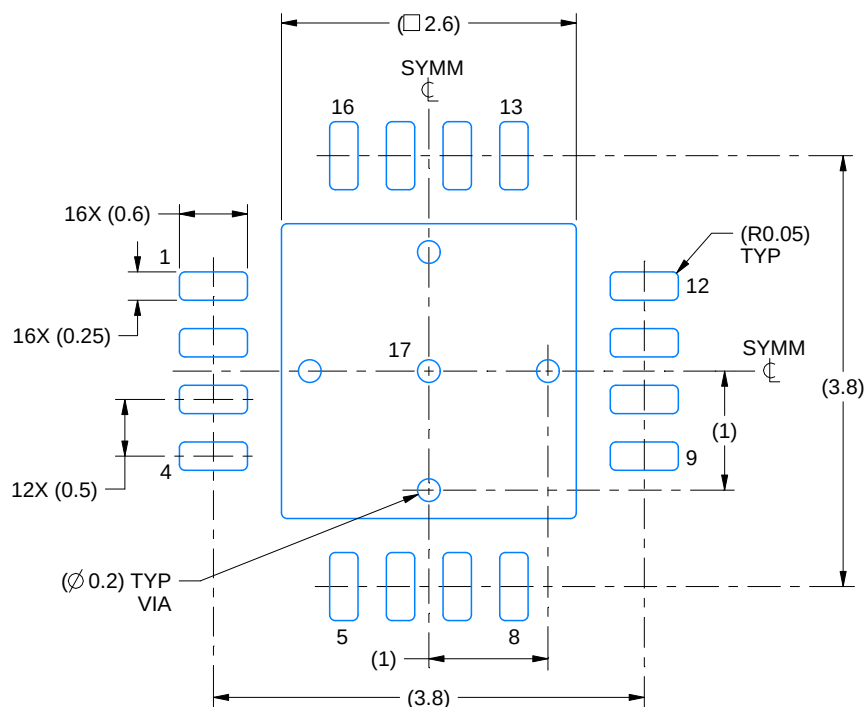
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for optimal thermal and mechanical performance.

EXAMPLE BOARD LAYOUT

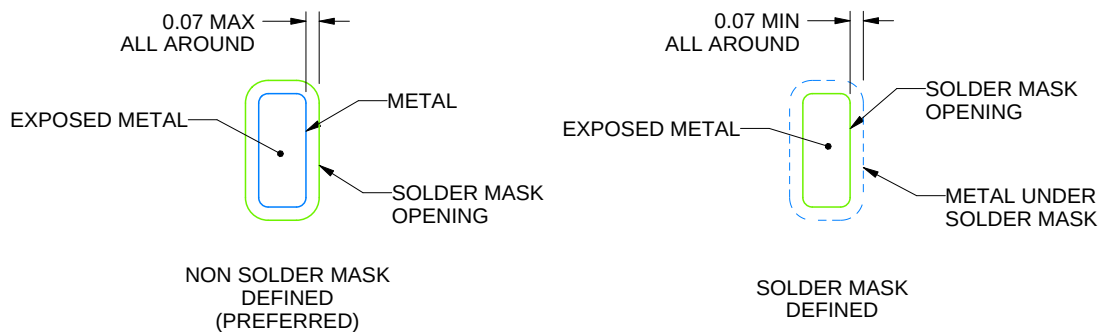
RGH0016A

WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:15X



SOLDER MASK DETAILS

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NOTES: (continued)

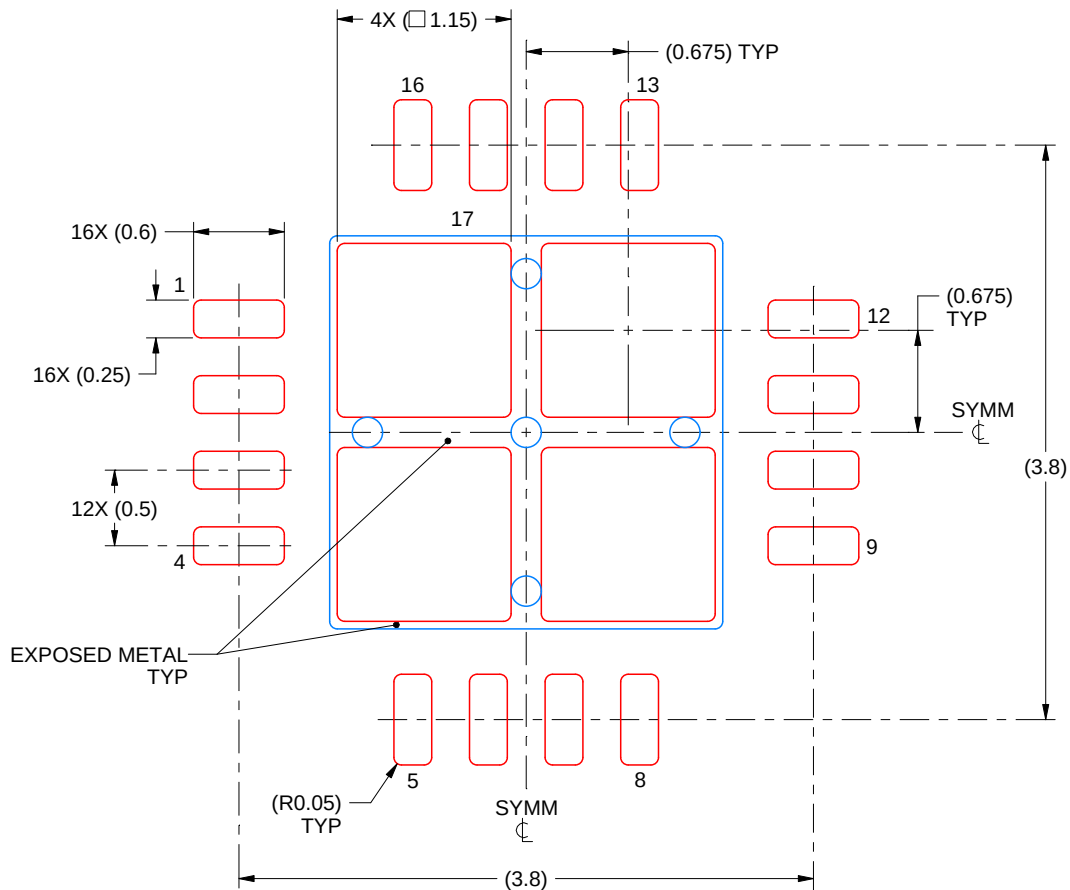
- This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/sluea271).
- Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

EXAMPLE STENCIL DESIGN

RGH0016A

WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD 17
78% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE
SCALE:20X

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NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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